TOSHIBA Field Effect Transistor Silicon N Channel MOS Type

# SSM3K01T

#### **High Speed Switching Applications**

Unit: mm

• Small Package

• Low on Resistance:  $R_{on}$  = 120 m $\Omega$  (max) (@VGS = 4 V) :  $R_{on}$  = 150 m $\Omega$  (max) (@VGS = 2.5 V)

• Low Gate Threshold Voltage:  $V_{th} = 0.6 \sim 1.1 \text{ V}$ 

 $(@V_{DS} = 3 \text{ V}, I_{D} = 0.1 \text{ mA})$ 

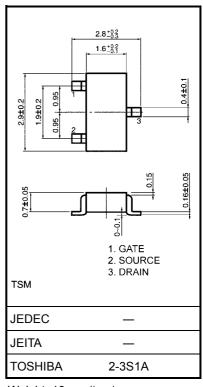
#### **Maximum Ratings (Ta = 25°C)**

| Characteristic                      |       | Symbol                     | Rating         | Unit |
|-------------------------------------|-------|----------------------------|----------------|------|
| Drain-Source voltage                |       | $V_{DS}$                   | 30             | V    |
| Gate-Source voltage                 |       | $V_{GSS}$                  | ±10            | V    |
| Drain current                       | DC    | I <sub>D</sub>             | 3.2            |      |
|                                     | Pulse | I <sub>DP</sub><br>(Note2) | 6.4            | Α    |
| Drain power dissipation (Ta = 25°C) |       | P <sub>D</sub><br>(Note1)  | 1250           | mW   |
| Channel temperature                 |       | T <sub>ch</sub>            | 150            | °C   |
| Storage temperature range           |       | T <sub>stg</sub>           | <b>−55~150</b> | °C   |

Note1: Mounted on FR4 board

 $(25.4 \text{ mm} \times 25.4 \text{ mm} \times 1.6 \text{ t}, \text{ Cu pad: } 645 \text{ mm}^2, \text{ t} = 10 \text{ s})$ 

Note2: The pulse width limited by max channel temperature.



Weight: 10 mg (typ.)

## **Handling Precaution**

When handling individual devices (which are not yet mounted on a circuit board), be sure that the environment is protected against electrostatic electricity. Operators should wear anti-static clothing, and containers and other objects that come into direct contact with devices should be made of anti-static materials. The Channel-to-Ambient thermal resistance  $R_{th}$  (ch-a) and the drain power dissipation  $P_D$  vary according to the board material, board area, board thickness and pad area, and are also affected by the environment in

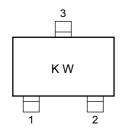
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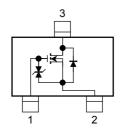
which the product is used. When using this device, please take heat dissipation fully into account.

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#### Marking

## **Equivalent Circuit**





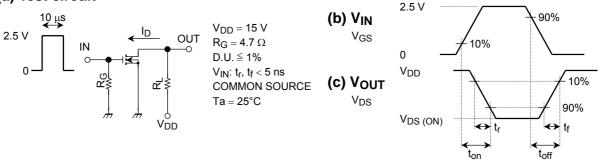
#### **Electrical Characteristics (Ta = 25°C)**

| Characteristic                 |               | Symbol               | Test Condition   | Min | Тур. | Max | Unit |  |
|--------------------------------|---------------|----------------------|--|-----|------|-----|------|--|
| Gate leakage current           |               | I <sub>GSS</sub>     | $V_{GS} = \pm 10 \text{ V}, V_{DS} = 0$                | _   | _    | ±1  | μΑ   |  |
| Drain-Source breakdown voltage |               | V (BR) DSS           | $I_D = 1 \text{ mA}, V_{GS} = 0$                       | 30  | _    | _   | V    |  |
| Drain Cut-off current          |               | I <sub>DSS</sub>     | V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0            | _   | _    | 1   | μΑ   |  |
| Gate threshold voltage         |               | $V_{th}$             | $V_{DS} = 3 \text{ V}, I_D = 0.1 \text{ mA}$           | 0.6 | _    | 1.1 | V    |  |
| Forward transfer admittance    |               | Y <sub>fs</sub>      | $V_{DS} = 3 \text{ V}, I_D = 1.6 \text{ A}$ (Note3)    | 2.6 | 5.2  | _   | S    |  |
| Drain-Source ON resistance     |               | R <sub>DS (ON)</sub> | $I_D = 1.6 \text{ A}, V_{GS} = 4 \text{ V}$ (Note3)    | _   | 85   | 120 | mΩ   |  |
| Drain-Source ON resistance     |               | R <sub>DS (ON)</sub> | $I_D = 1.3 \text{ A}, V_{GS} = 2.5 \text{ V}$ (Note3)  | _   | 115  | 150 | mΩ   |  |
| Input capacitance              |               | C <sub>iss</sub>     | V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0, f = 1 MHz | _   | 152  | _   | pF   |  |
| Reverse transfer capacitance   |               | C <sub>rss</sub>     | V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0, f = 1 MHz | _   | 41   | _   | pF   |  |
| Output capacitance             |               | Coss                 | V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0, f = 1 MHz | _   | 102  | _   | pF   |  |
| Switching time                 | Turn-on time  | t <sub>on</sub>      | V <sub>DD</sub> = 15 V, I <sub>D</sub> = 0.5 A         | _   | 45   | _   | nS   |  |
|                                | Turn-off time | t <sub>off</sub>     | $V_{GS} = 0~2.5 \text{ V}, R_G = 4.7 \Omega$           |     | 69   |     |      |  |

Note3: Pulse test

## **Switching Time Test Circuit**

### (a) Test circuit



#### **Precaution**

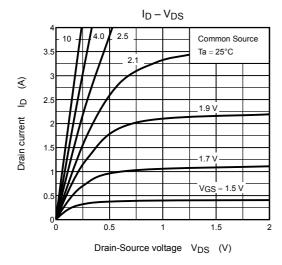
 $V_{th}$  can be expressed as voltage between gate and source when low operating current value is  $I_D$  = 100  $\mu A$  for this product. For normal switching operation,  $V_{GS}$  (on) requires higher voltage than  $V_{th}$  and  $V_{GS}$  (off) requires lower voltage than  $V_{th}$ .

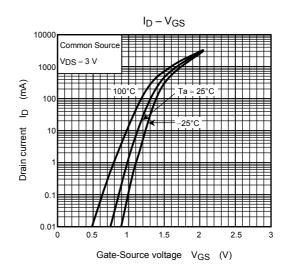
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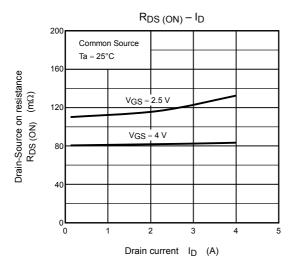
(relationship can be established as follows:  $V_{GS \text{ (off)}} < V_{th} < V_{GS \text{ (on)}}$ )

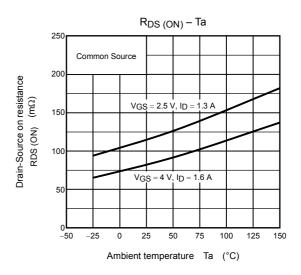
Please take this into consideration for using the device.

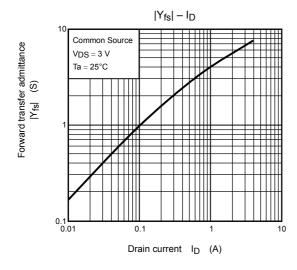
 $V_{\mathrm{GS}}$  recommended voltage of 2.5 V or higher to turn on this product.

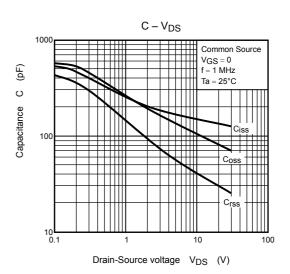


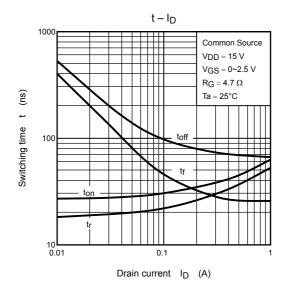


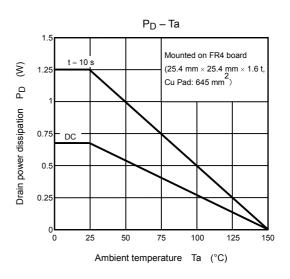


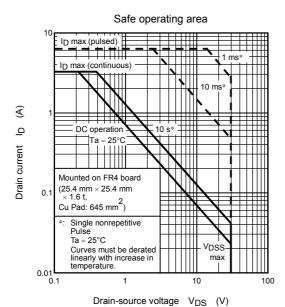


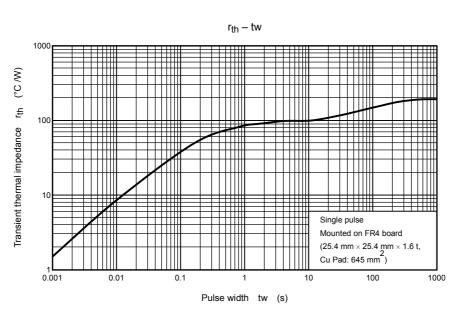












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